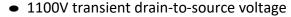
1100V E-mode GaN transistor

Preliminary Datasheet

Features

 BVdss
 Rdson
 Ids
 Q_g V_{gs} V_{th}

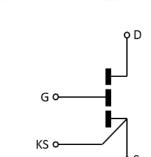
 1100 V
 60 mΩ
 30 A
 8.25 nC
 ±20 V
 2.7 V



- Pin-to-Pin compatible with MOSFET
- Larger Vgs range
- High Vth
- High dv/dt
- Ultra-low Rdson
- Extremely low input capacitance
- Zero Qrr
- Outstanding switching performance

Applications

- Switching Power Applications
- Adapters
- Quick Chargers



Description

These devices are N-channel 1100 V Power GaN HEMTs based on proprietary E-mode GaN on silicon technology. The resulting product has extremely low on state resistance, very low input capacitance and zero reverse recovery charge making it especially suitable for applications which require superior power density, ultra-high switching frequency and outstanding efficiency.

Ordering Information

| Order Code | Package Type | Packaging Method | Qty |
|------------|--------------|------------------|--------------------------|
| GP120R60T4 | TO247-4 | Tube | 30pcs/Tube 240pcs/Box |



GP120R60T4

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Device Characteristics

| Static Parameters | | | Test data | | | | |
|-----------------------|------------------------------|---|---|-----|---------|-----|------|
| | Parameters | | Conditions | Min | Typical | Max | Unit |
| 1 | V _{gs(TH)} | Gate threshold voltage | V _{ds} =V _{gs} , I _d =21 mA (T _J =25 °C) | 1.5 | 2.7 | 4 | V |
| 2 | V _{GS} ¹ | Gate-Source voltage range | | -20 | 6~12 | 20 | V |
| 3 | BV_{dss^2} | Drain-Source breakdown voltage | V_{gs} =0V, I_{d} < 1 mA (T_{J} =25 °C) | | 1100 | | V |
| 4 | l _{dss} | Zero gate voltage drain leakage current | V_{gs} =0V, V_{ds} = 700V T_{J} = 25 °C | | 250 | 950 | μА |
| 5 | I _{gss} | Gate-Source Leakage | $V_{gs} = 6V$, $V_{ds} = 0V$ | | 0.7 | 30 | mA |
| 6 | R _{dson} | drain-source on resistance | $V_{gs} = 6V, I_{d} = 0.8A$ $T_{J} = 25 {}^{\circ}C$ | | 42 | 60 | mΩ |
| 7 | V_{sd} | Reverse conduction voltage | I _{sd} =0.12A, V _{gs} =0V | 1.2 | 2.0 | 3 | V |
| 8 | R _g | Gate resistance | f=25Mhz Open drain | | 1.5 | | Ω |
| Dyr | namic Paramet | ers | | | Test da | ata | |
| | Parameters | | Conditions | Min | Typical | Max | Unit |
| 1 | C _{ISS} | Input capacitance | V _{gs} = 0 V | | 236 | | pf |
| 2 | Coss | Output capacitance | V _{ds} = 700 V | | 72 | | pf |
| 3 | C _{RSS} | Reverse transfer capacitance | f = 1MHz | | 4.6 | | pf |
| 4 | Qg | Gate charge | Vds = 400V | | 8.25 | | nC |
| 5 | Q_{gs} | Gate to source charge | Id = 9A | | 1.5 | | nC |
| 6 | Q_{gd} | Gate to drain charge | Vgs = 6V | | 1.8 | | nC |
| 7 | Q _{rr} | Reverse recovery charge | | | 0 | | nC |
| Switching Performance | | Test data | | | | | |
| | Parameters | | Conditions | Min | Typical | Max | Unit |
| 1 | t _{d(on)} | Turn-on delay time | V. = 900V | | 34 | | ns |
| 2 | t _r | Rise time | $V_{ds} = 800V$ $I_{d} = 15A$ | | 26 | | ns |
| 3 | t _{d(off)} | Turn-off delay time | $R_g = 10\Omega$ | | 33 | | ns |
| 5 | -4(011) | · a o a.e.a.,e | S | | | | _ |
| 4 | t _f | Fall time | V _{gs} = -3/6.5V | | 20 | | ns |

¹ A wider range of gate driving from-20V to 20V can be accepted, but recommended range is still -3V to 6.5V. Wider range protects the gate from damage, but at some cost of power loss.

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 $^{^{2}\,}$ BV_{dss} refers to DC withstanding voltage. This product is recommended for DC bus voltage of 800-1000V.



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Absolute Max. Ratings

| | Symbols | Parameters | Value | Unit |
|---|------------------------|---|------------|------|
| 1 | $V_{\text{DS-max}}$ | Breakdown voltage transient @ T _{case} =25 C | 1100 | V |
| 2 | $V_{\text{DS-max}}$ | Breakdown voltage transient @ T _{case} =125 C | 1000 | V |
| 3 | V_{GS-max} | Gate to source max. voltage @ T _{case} =25°C | -20 to +20 | V |
| 4 | I _{ds-max} | Drain to source pulse current @ $T_{case}=25^{\circ}$ C, pulse width 10 μ s, $V_{GS}=6$ V | 30 | А |
| 5 | I _{ds-max} | Drain to source pulse current @ T _{case} =150 C | 22 | А |
| 6 | dv/dt _{-max} | Drain to source voltage slew rate | 200 | V/ns |
| 7 | T _{J-max} | Max junction temperature | 150 | °C |
| 8 | $T_{S\text{-storage}}$ | Storage temperature | -55 to 150 | °C |

Thermal and Soldering Characteristics (Typical)

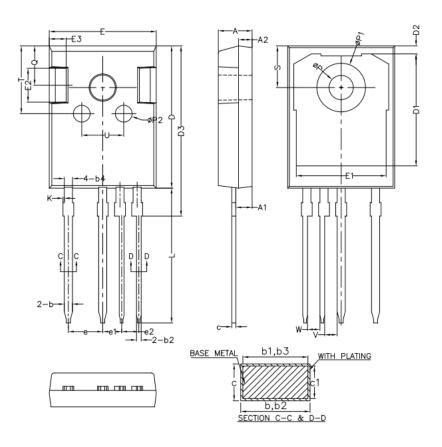
| | Symbols | Parameters | Value | Unit |
|---|--------------|--|-------|------|
| 1 | R_{thJC} | Thermal resistance (junction to case) | 0.6 | °C/W |
| 2 | R_{thJA} | Thermal resistance (junction to ambient) | 62 | °C/W |
| 3 | T_{solder} | Reflow soldering temperature | 250 | °C |



1100V E-mode GaN transistor

Preliminary Datasheet

Package Information



| COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER) | | | | | |
|--|-------|-------|-------|--|--|
| SYMBOL | MIN | NOM | MAX | | |
| Α | 4.90 | 5.00 | 5.10 | | |
| A1 | 2.31 | 2.41 | 2.51 | | |
| A2 | 1.90 | 2.00 | 2.10 | | |
| b | 1.16 | - | 1.29 | | |
| b1 | 1.15 | 1.20 | 1.25 | | |
| b2 | 0.66 | - | 0.79 | | |
| b3 | 0.65 | 0.70 | 0.75 | | |
| b4 | 1.16 | - | 1.29 | | |
| С | 0.59 | - | 0.66 | | |
| c1 | 0.58 | 0.60 | 0.62 | | |
| D | 20.90 | 21.00 | 21.10 | | |
| D1 | 16.25 | 16.55 | 16.85 | | |
| D2 | 1.05 | 1.20 | 1.35 | | |
| D3 | 24.97 | 25.12 | 25.27 | | |
| E | 15.70 | 15.80 | 15.90 | | |
| E1 | 13.10 | 13.30 | 13.50 | | |
| E2 | 4.90 | 5.00 | 5.10 | | |
| E3 | 2.40 | 2.50 | 2.60 | | |
| е | 4.98 | 5.08 | 5.18 | | |
| e1 | 2.69 | 2.79 | 2.89 | | |
| e2 | 2.44 | 2.54 | 2.64 | | |
| K | 0 | - | 0.20 | | |
| L | 19.80 | 19.92 | 20.10 | | |
| Р | 3.50 | 3.60 | 3.70 | | |
| P1 | _ | - | 7.40 | | |
| P2 | 2.40 | 2.50 | 2.60 | | |
| Q | 5.60 | - | 6.00 | | |
| S | 6.00 | 6.15 | 6.30 | | |
| T | 9.80 | _ | 10.20 | | |
| U | 6.00 | - | 6.40 | | |
| > | 1.44 | 1.84 | 2.24 | | |
| W | 1.44 | 1.84 | 2.24 | | |

IOTES:

1.ALL DIMENSIONS DO NOT INCLUDE MOLD FLASH OR PROTRUSIONS.

2.EJECTION MARK DEPTH 0.10+0.15 0.05.



GP120R60T4

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Further information

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Data Source— Data here are based on recent tests but all parameters may not be up to date. Actual final test data from packaging production are available for selected customers upon request.